

### SLOVENSKI STANDARD SIST EN 61000-4-34:2007/A1:2009

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Electromagnetic compatibility (EMC) -- Part 4-34: Testing and measurement techniques -Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current more than 16 A per phase

iTeh STANDARD PREVIEW

Elektromagnetische Verträglichkeit (EMV) - Teil 4-341 Prüf- und Messverfahren -Prüfungen der Störfestigkeit von Geräten und Einrichtungen mit einem Eingangsstrom > 16 A je Leiter gegen Spannungseinbrüche, Kurzzeitunterbrechungen und Spannungsschwankungenndards.iteh.ai/catalog/standards/sist/eeca430e-c225-42f2-9410b6da204ab1a3/sist-en-61000-4-34-2007-a1-2009

Compatibilité électromagnétique (CEM) -- Partie 4-34: Techniques d'essai et de mesure -Essais d'immunité aux creux de tension, coupures brèves et variations de tension pour matériel ayant un courant appelé de plus de 16 A par phase

Ta slovenski standard je istoveten z: EN 61000-4-34:2007/A1:2009

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33.100.20 **Imunost Immunity** 

SIST EN 61000-4-34:2007/A1:2009 en.fr SIST EN 61000-4-34:2007/A1:2009

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EN 61000-4-34/A1

NORME EUROPÉENNE EUROPÄISCHE NORM

August 2009

ICS 33.100.20

English version

Electromagnetic compatibility (EMC) Part 4-34: Testing and measurement techniques Voltage dips, short interruptions and voltage variations immunity tests
for equipment with mains current more than 16 A per phase
(IEC 61000-4-34:2005/A1:2009)

Partie 4-34: Techniques d'essai

et de mesure -

Essais d'immunité aux creux de tension,

Compatibilité électromagnétique (CEM) -

coupures brèves et variations de tension

pour matériel ayant un courant d'alimentation de plus de 16 À par phase

d'alimentation de plus de 16 A par phase (CEI 61000-4-34:2005/A1:2009) and ards.ite

Elektromagnetische Verträglichkeit (EMV) -Teil 4-34: Prüf- und Messverfahren -

Prüfungen der Störfestigkeit von Geräten und Einrichtungen

mit einem Netzstrom > 16 A je Leiter gegen Spannungseinbrüche,

Kurzzeitunterbrechungen und Spannungsschwankungen

SIST EN 61000-4-34:2007/A(IEG) 61000-4-34:2005/A1:2009)

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b6da204ab1a3/sist-en-61000-4-34-2007-a1-2009

This amendment A1 modifies the European Standard EN 61000-4-34:2007; it was approved by CENELEC on 2009-07-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this amendment the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This amendment exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

### **CENELEC**

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

#### **Foreword**

The text of document 77A/670/CDV, future amendment 1 to IEC 61000-4-34:2005, prepared by SC 77A, Low frequency phenomena, of IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as amendment A1 to EN 61000-4-34:2007 on 2009-07-01.

The following dates were fixed:

 latest date by which the amendment has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2010-04-01

 latest date by which the national standards conflicting with the amendment have to be withdrawn

(dow) 2012-07-01

#### **Endorsement notice**

The text of amendment 1:2009 to the International Standard IEC 61000-4-34:2005 was approved by CENELEC as an amendment to the European Standard without any modification.

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### IEC 61000-4-34

Edition 1.0 2009-05

## INTERNATIONAL **STANDARD**

## **NORME** INTERNATIONALE

**BASIC EMC PUBLICATION** 

PUBLICATION FONDAMENTALE EN CEM

AMENDMENT 1

## AMENDEMENT 1 iTeh STANDARD PREVIEW

(standards.iteh.ai)

Electromagnetic compatibility (EMC) – SIST EN 61000-4-34:2007/A1:2009

Part 4-34: Testing and measurement techniques 10-Voltage dips, short interruptions and voltage variations immunity tests for equipment with mains current more than 16 A per phase

Compatibilité électromagnétique (CEM) -

Partie 4-34: Techniques d'essai et de mesure – Essais d'immunité aux creux de tension, coupures brèves et variations de tension pour matériel ayant un courant d'alimentation de plus de 16 A par phase

INTERNATIONAL **ELECTROTECHNICAL COMMISSION** 

COMMISSION **ELECTROTECHNIQUE INTERNATIONALE** 

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61000-4-34 Amend. 1 © IEC:2009

#### **FOREWORD**

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This amendment has been prepared by subcommittee 77A: Low frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

The text of this amendment is based on the following documents:

Enquiry draft	Report on voting
77A/670/CDV	77A/688/RVC

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this amendment and the base publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- · withdrawn,
- · replaced by a revised edition, or
- amended.

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#### Main title

SIST EN 61000-4-34:2007/A1:2009

https://standards.itch.ai/catalog/standards/sist/eeca430e-c225-42f2-9410-Replace the part title on the cover page, the title page, above the Foreword and the Scope by the following:

## Part 4-34: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with mains current more than 16 A per phase

#### 1 Scope

Replace the entire second paragraph of the scope by the following:

This standard applies to electrical and electronic equipment having a rated mains current exceeding 16 A per phase. (See Annex E for guidance on electrical and electronic equipment rated at more than 200 A per phase.) It covers equipment installed in residential areas as well as industrial machinery, specifically voltage dips and short interruptions for equipment connected to either 50 Hz or 60 Hz a.c. networks, including 1-phase and 3-phase mains.

NOTE 1 Equipment with a rated mains current of 16 A or less per phase is covered by publication IEC 61000-4-11.

NOTE 2 There is no upper limit on rated mains current in this publication. However, in some countries, the rated mains current may be limited to some upper value, for example 75 A or 250 A, because of mandatory safety standards

#### 3.6 rated input voltage

Delete this term and definition and renumber the following terms and definitions accordingly.

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#### 5 Test levels

Modify the first sentence as follows:

The voltages in this standard use the rated voltage for the equipment as a basis for voltage test level specification  $(U_T)$ .

#### 5.1 Voltage dips and short interruptions

Delete the last two paragraphs before Table 1, beginning with "Shorter durations in the table...", and ending with "...after the voltage dip."

Table 1 - Preferred test level and durations for voltage dips

Replace the existing Table 1 by the following new Table 1:

Classesa	Test level and durations for voltage dips $(t_{ m s})$ (50 Hz/60 Hz)			
Class 1	Case-by-case according to the equipment requirements			
Class 2	0 % during 1 cycle	70 % during 25/30 <sup>c</sup> cycles		
Class 3	0 % during 1 cycle	40 % <sup>d</sup> during 10/12 <sup>c</sup> cycles	70 % during 25/30 <sup>c</sup> cycles	80 % during 250/300 <sup>c</sup> cycles
Class X <sup>b</sup>	iTeh STA	NDARD PI	REVIEW	Х

Classes as per IEC 61000-2-4; see Agree Bidards.iteh.ai)

#### 5.2 Voltage variations (optional)

Add the following paragraph immediately below Table 3:

For voltage variations in three-phase systems with or without neutral, all the three phases shall be tested simultaneously. Simultaneous voltage variations in three-phase systems are positioned at the zero-crossing of one of the voltages.

To be defined by product committee. For equipment connected directly or indirectly to public network, the levels must not be less severe than class 2<sub>SIST EN 61000-4-34:2007/A1:2009</sub>

<sup>&</sup>lt;sup>c</sup> "25/30 cycles" mean<mark>s: "25/cycles for:50.Hz:test" and "30 cycles for:60.Hz:test".2f10)42 cycles" means "10 cycles for 50 Hz test" and "12 cycles for:60.Hz test" and "250/300 cycles" means "250 cycles for:50 Hz test" and "300 cycles for:60 Hz test".</mark>

May be replaced by product committee with a test level of 50 % for equipment that is intended primarily for 200 V or 208 V nominal operation.

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#### Table 4 - Generator specifications

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#### Replace the existing Table 4 by the following new Table 4:

Output voltage at no load	As required in Table 1, $\pm 5$ % of residual voltage value		
Voltage at the output of the generator during equipment test	As required in Table 1, $\pm 10$ % of residual voltage value, measured as r.m.s. value refreshed each ½ cycle per IEC 61000-4-30		
Output current capability	See Annex A		
Peak inrush current capability (no requirement for voltage variation tests)	See Annex A		
Instantaneous peak overshoot/undershoot of the actual voltage, generator loaded with resistive load – see NOTE 1	Less than 5 % of $U_{T}$		
Voltage rise (and fall) time $t_{\rm r}$ (and $t_{\rm f}$ ), during abrupt change, generator loaded with resistive load – see NOTE A and NOTE 1	Between 1 μs and 5 μs for current ≤75 A  Between 1 μs and 50 μs for current >75 A		
Phase angle at which the voltage dip begins and ends	0° to 360° with a maximum resolution of 5°, see NOTE B		
Phase relationship of voltage dips and interruptions with the power frequency	Less than ±5°		
Zero crossing control of the generators	±10°		
NOTE A These values must be checked with a resistive load as per NOTE 1 after this table, but they need not be checked when an EUT is connected.			
NOTE B Phase angle adjustment may be required to comply with 5.1.			

#### SIST EN 61000-4-34:2007/A1:2009

#### 6.1.1 Characteristics/and performance/of the generatore-c225-42f2-9410-

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Replace the last sentence before NOTE 1 by the following:

For generating interruptions, a high impedance open circuit is permitted.

#### 8.2.1 Voltage dips and short interruptions

Delete, in the second paragraph, "except for ½ cycle test which shall occur at 90°"

Delete the entire NOTE after the second paragraph.

Replace the last sentence of the sixth paragraph by the following:

See Figure 3a, Figure 3b and Figure 3c.

Replace the last sentence of the seventh paragraph by the following:

See Figure 3b and Figure 3c.

#### Annex A – Test generator peak inrush current drive capability

Replace the title of Annex A as follows:

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### Annex A (normative)

#### Test generator current drive capability

Add the following new paragraph as the second paragraph of Annex A:

During voltage dip testing on polyphase loads, the current on non-dipped phases may increase to as much as 200 % of the rated current, for the duration of the dip.

Replace the existing second paragraph (now third paragraph) by the following:

Current capability at the output of a test generator may be a function of both the test generator and of the a.c. mains source that supplies power to the test generator.

Add, after Figure A.1, the following new Clause to Annex A:

#### A.3 Test generator requirement during dip current

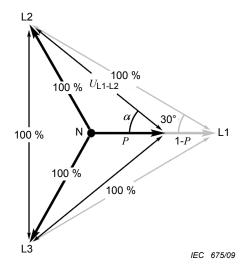
During dip tests on polyphase loads, the test generator shall be capable of supplying sufficient current on the non-dipped phase conductors, during the dip, to maintain the voltages required in Table 1,  $\pm 10$  %, measured as r.m.s. value (average time 1 cycle) refreshed each ½ cycle as per IEC 61000-4-30.RD) PREVIEW

NOTE During the dip, the current on the non-dipped phase conductors may be as much as 200 % of the rated current.

Figure C.1 - Phase-to-neutral dip vectors 0-4-34:2007/A1:2009

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Replace the existing Figure 6.1/2.by athe following 00-4-34-2007-a1-2009



$$\alpha = \sin^{-1} \left( \frac{\sin(120^{\circ})}{\sqrt{1 + P^2 - 2P\cos(120^{\circ})}} \right)$$
 (C.1)

$$U_{\text{L1-L2}} = \frac{\sqrt{1 + P^2 - 2P\cos(120^\circ)}}{\sqrt{3}}$$
 (C.2)

*P* is the percent phase-to-neutral dip, expressed as a fraction of the nominal phase-to-neutral voltage.

 $U_{\mathsf{L1-L2}}$  is the voltage from L1 to L2, expressed as a fraction of the nominal phase-to-phase voltage.

NOTE The  $\sin^{-1}$  function is ambiguous (there are always two angles that have the same value), and return values between  $-90^{\circ}$  and  $+90^{\circ}$ , so the correct quadrant must be selected.